



Corrigendum

Corrigendum to “Characterization and studying of ZnO thin films deposited by spray pyrolysis: Effect of annealing temperature” [Optik – Int. J. Light Electron Optics 127 (February (4)) (2016) 2336–2340]



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We would like to update the author group. The correct authorship is provided above.
The authors would like to apologise for any inconvenience caused.

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